



High-end Power Semiconductor Manufacturer

# KP2810A 6500V

## Phase Control Thyristor

- High power cycling capability
- Low on-state and switching losses
- Designed for traction and industrial applications



Mean on-state current	$I_{TAV}$	2810 A
Repetitive peak off-state voltage	$V_{DRM}$	
Repetitive peak reverse voltage	$V_{RRM}$	6500 V
Turn-off time	$t_q$	800 $\mu$ s
$T_{vj}$ , °C	125	

### MAXIMUM ALLOWABLE RATINGS

Symbols and parameters		Units	Values	Test conditions	
<b>ON-STATE</b>					
$I_{TAV}$	Mean on-state current	A	2810	$T_c=70$ °C, half-sine wave	
$I_{TRMS}$	RMS on-state current	A	4410	$T_c=70$ °C, half-sine wave	
$I_{TSM}$	Surge on-state current	kA	45.0	$t_p = 10$ ms	$T_{vj}= 125$ °C, $V_D = V_R = 0$ V
			50.0	$t_p = 8.3$ ms	$T_{vj}= 125$ °C, $V_D = V_R = 0$ V
$I^2t$	Safety factor	$A^2 \cdot 10^3$	10125	$t_p = 10$ ms	$T_{vj}= 125$ °C, $V_D = V_R = 0$ V
			10375	$t_p = 8.3$ ms	$T_{vj}= 125$ °C, $V_D = V_R = 0$ V
<b>BLOCKING</b>					
$V_{DRM}, V_{RRM}$	Repetitive peak off-state and Repetitive peak reverse voltages	V	5600	$f = 50$ Hz, $t_p = 10$ ms	
$V_D, V_R$	Direct off-state and Direct reverse voltages	V	$0.6 \cdot V_{DRM}$ $0.6 \cdot V_{RRM}$	$T_j=T_{j\max}$ ; Gate open	

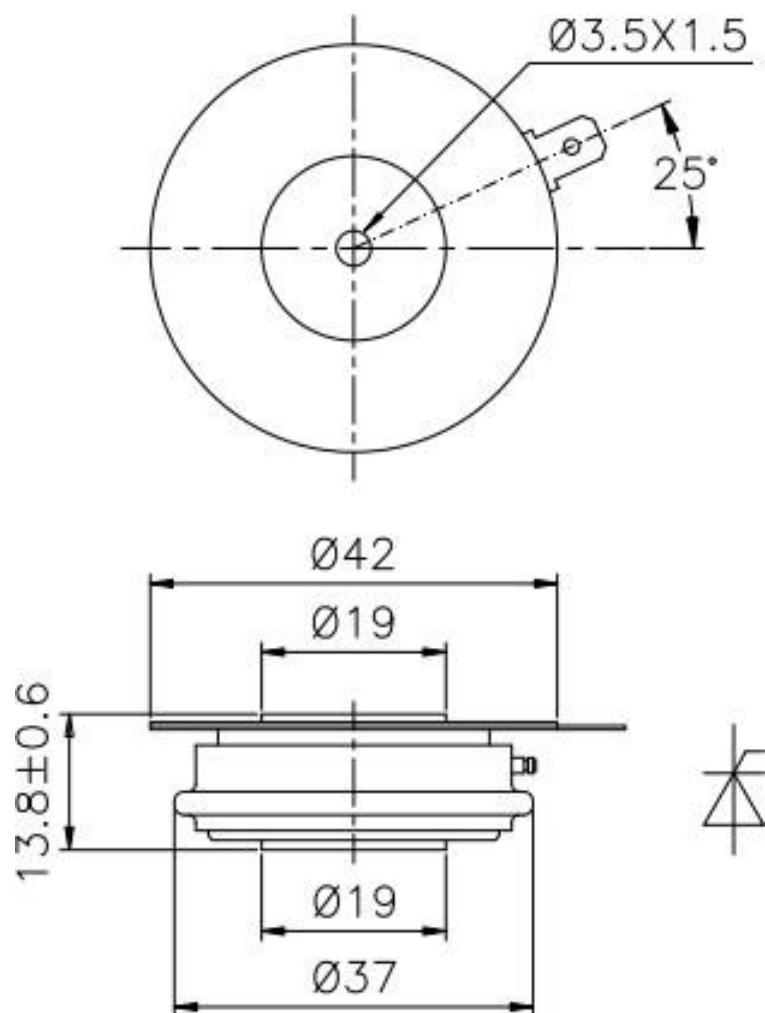
TRIGGERING				
I <sub>FGM</sub>	Peak forward gate current	A	10	T <sub>j</sub> =T <sub>j max</sub>
V <sub>RGM</sub>	Peak reverse gate voltage	V	10	
P <sub>G</sub>	Gate power dissipation	W	3	
SWITCHING				
(di <sub>T</sub> /dt) <sub>crit</sub>	Critical rate of rise of on-state current non-repetitive (f=1 Hz)	A/μs	1000	T <sub>vj</sub> = 125 °C, I <sub>TRM</sub> = 3000 A, V <sub>D</sub> ≤ 0.67.V <sub>DRM</sub> , I <sub>FG</sub> = 2 A, t <sub>r</sub> = 0.5 μs
THERMAL				
T <sub>stg</sub>	Storage temperature	°C	-40-140	
T <sub>vj</sub>	Operating junction temperature	°C	125	
MECHANICAL				
F	Mounting force	kN	81-108	
a	Acceleration	m/s <sup>2</sup>	50 100	Device unclamped Device clamped

## CHARACTERISTICS

Symbols and parameters		Units	Values	Conditions
ON-STATE				
V <sub>TM</sub>	Peak on-state voltage, max	V	2.00	I <sub>T</sub> = 3000 A, T <sub>vj</sub> = 125 °C
V <sub>T(TO)</sub>	On-state threshold voltage, max	V	1.12	
r <sub>T</sub>	On-state slope resistance, max	mΩ	0.29	I <sub>T</sub> = 1300 A - 4000 A, T <sub>vj</sub> = 125 °C
I <sub>L</sub>	Latching current, max	mA	500	T <sub>vj</sub> =25°C
I <sub>H</sub>	Holding current, max	mA	125	T <sub>vj</sub> =25°C
BLOCKING				
I <sub>DRM</sub> , I <sub>RRM</sub>	Repetitive peak off-state and Repetitive peak reverse currents, max	mA	600	V <sub>DRM</sub> , T <sub>vj</sub> = 125 °C
(dv <sub>D</sub> /dt) <sub>crit</sub>	Critical rate of rise of off-state voltage <sup>1)</sup>	V/μs	2000	Exp. to 0.67 x V <sub>DRM</sub> , T <sub>vj</sub> = 125 °C
TRIGGERING				
V <sub>GT</sub>	Gate trigger direct voltage, max	V	2.60	T <sub>vj</sub> =25 °C
I <sub>GT</sub>	Gate trigger direct current, max	mA	400	T <sub>vj</sub> = 25 °C
SWITCHING				
t <sub>gd</sub>	Delay time	μs	3.00	V <sub>D</sub> = 0.4.V <sub>DRM</sub> , I <sub>FG</sub> = 2 A, t <sub>r</sub> = 0.5 μs
t <sub>q</sub>	Turn-off time <sup>2)</sup>	μs	800	T <sub>vj</sub> = 125 °C, I <sub>TRM</sub> = 3000 A, V <sub>R</sub> = 200 V, di <sub>T</sub> /dt = -1 A/μs, V <sub>D</sub> ≤ 0.67.V <sub>DRM</sub> , dv <sub>D</sub> /dt = 20 V/μs
Q <sub>rr</sub>	Total recovered charge, max	μAs	3700	T <sub>vj</sub> = 125 °C, I <sub>TRM</sub> = 3000 A, V <sub>R</sub> = 200 V, di <sub>T</sub> /dt = -1 A/μs

<b>THERMAL</b>					
$R_{thjc}$	Thermal resistance, junction to case, max	K/kW	5.7	Direct current	Double side cooled
$R_{thjc-A}$			11.4		Anode side cooled
$R_{thjc-K}$			11.4		Cathode side cooled
$R_{thck}$	Thermal resistance, case to heatsink, max	K/kW	1	Double-side cooled	
<b>MECHANICAL</b>					
W	Weight, typ	g	2900		
$D_s$	Surface creepage distance	mm	56		
$D_a$	Air strike distance	mm	22		

## OVERALL DIMENSIONS



All dimensions in millimeters